

Notice of References Cited	Application/Control No. 10/533,309		Applicant(s)/Patent Under Reexamination OKAMOTO ET AL.	
	Examiner ROBERT LOEWE		Art Unit 1796	Page 1 of 2

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,310,640 A	01-1982	Kato et al.	525/100
*	B	US-4,559,387 A	12-1985	Endo et al.	525/102
*	C	US-4,818,790 A	04-1989	Ooka et al.	525/103
*	D	US-4,904,721 A	02-1990	Hanaoka et al.	524/266
*	E	US-4,910,255 A	03-1990	Wakabayashi et al.	525/100
*	F	US-4,977,228 A	12-1990	Wakabayashi et al.	528/12
*	G	US-4,994,327 A	02-1991	Kato et al.	428/447
*	H	US-5,030,691 A	07-1991	Kohmitsu et al.	525/100
*	I	US-5,306,759 A	04-1994	Sakagami et al.	524/379
*	J	US-6,166,163 A	12-2000	Kudo et al.	528/14
*	K	US-6,207,766 B1	03-2001	Doi et al.	525/403
*	L	US-2001/0031315 A1	10-2001	Okamoto et al.	427/372.2
*	M	US-2002/0010271 A1	01-2002	Toui et al.	525/100

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 10/533,309		Applicant(s)/Patent Under Reexamination OKAMOTO ET AL.	
	Examiner ROBERT LOEWE		Art Unit 1796	Page 2 of 2

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0015795 A1	02-2002	Toui et al.	427/407.1
*	B	US-2002/0048680 A1	04-2002	Yamanaka, Yoshimichi	428/447
*	C	US-2002/0182529 A1	12-2002	Hoshi et al.	430/138
*	D	US-2003/0092863 A1	05-2003	Doi et al.	528/25
*	E	US-2003/0105261 A1	06-2003	Komitsu et al.	528/10
*	F	US-6,773,758 B2	08-2004	Yamanaka, Yoshimichi	427/407.1
*	G	US-2004/0176518 A1	09-2004	Okamoto et al.	524/442
*	H	US-2004/0198885 A1	10-2004	Okamoto et al.	524/394
*	I	US-7,045,004 B1	05-2006	Kasei et al.	106/287.16
*	J	US-7,094,841 B2	08-2006	Yamanaka, Yoshimichi	525/474
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.